Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination |
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| 10/785,254 | PANG, LINYONG |
| Examiner | Art Unit |
| Sun J. Lin | 2825 |

| SEARCHED | | | | | |
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| Class | Subclass | Date | Examiner | | |
| 716 | 19 | 11/7/2005 | JSL | | |
| 716 | 21 | 11/7/2005 | JSL | | |
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| SEARCH NOT (INCLUDING SEARCH | |) |
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| | DATE | EXMR |
| EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB | 11/7/2005 | JSL |
| IEEE | 11/7/2005 | JSL |
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